

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/617,855	LEE ET AL.	
Examiner	Art Unit	
Tawfik Goma	2653	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB) (see attached search history)	1/19/2006	TG		